

# **Enhancement Mode P-Channel Power MOSFET**

 $SOP8/PMOS/-30V/\pm20V/-1.6V/-12A/7.5m\Omega$ 

Rev<sub>0.8</sub>





# -30V, 7.5mΩ, -12A, P-Channel MOSFET

#### 1.Features

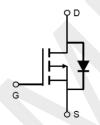
- Advanced Trench Technology
- ◆ Surface mount package

## 2.Applications

- Power Management
- Load Switching







Schematic Diagram

## 3. Package Marking and Ordering Information

Part no.	Marking	Package PCS/Reel		PCS/CTN.
WP4407	4407	SOP8	4,000	48,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	-30	V
Gate to Source Voltage	V <sub>GSS</sub>	±20	V
Drain Current (DC)	I <sub>D</sub>	-12	А
Drain Current (Pulse), PW≤300µs	I <sub>DP</sub>	-46	А
Single Pulse Avalanche Energy	EAS	55	mJ
Total Dissipation	P <sub>D</sub>	4.5	W
Junction Temperature	T <sub>j</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### 5.Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ hetaJA}$	40	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.



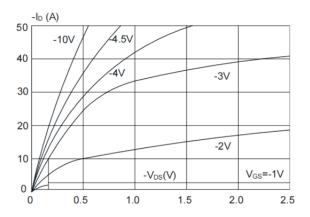
# 6.Electrical Characteristics at Ta=25°C (Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			٧
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30V, V_{GS} = 0V$			-1	μΑ
Gate to Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250μA	-1.0	-1.6	-2.5	>
Static Drain to Source On-State		I <sub>D</sub> =-12A, V <sub>GS</sub> =-10V		7.5	12	mΩ
Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =-8A, V <sub>GS</sub> =-4.5V		11.5	18	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V,		2800		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =-15V,		346		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	Frequency=1.0MHz		319		pF
Turn-ON Delay Time	t <sub>d(on)</sub>			14		ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =-15V, I <sub>D</sub> =-6A,		20		ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	$R_G = 2.5\Omega$ , $V_{GS} = -10V$		95		ns
Fall Time	t <sub>f</sub>			65		ns
	$Q_g$	V <sub>DS</sub> = -15V,		30		nC
Total Gate Charge	$Q_{gs}$	$V_{GS} = -10V$		5.3		nC
	$Q_{gd}$	I <sub>D</sub> = -12A		7.6		nC
Diode Forward Voltage	V <sub>FSD</sub>	I <sub>S</sub> = -12A, V <sub>GS</sub> = 0			-1.2	V

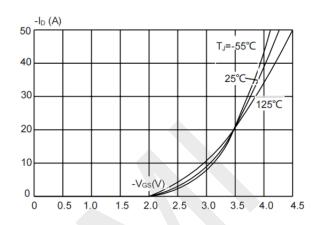
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



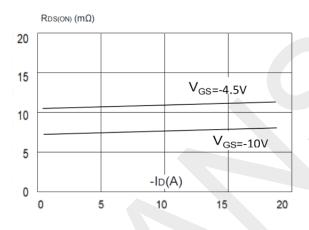
## 7. Typical Electrical and Thermal Characteristics



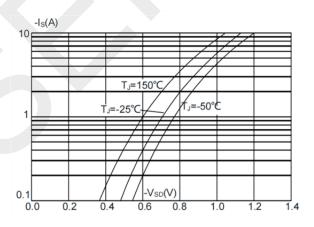
**Output Characteristics** 



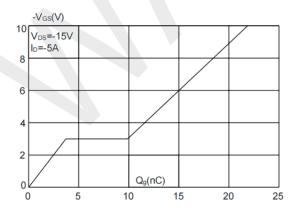
**Typical Transfer Characteristics** 



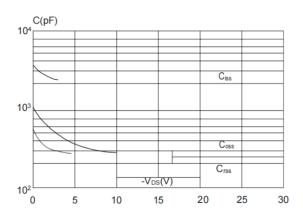
On-resistance vs. Drain Current



**Body Diode Characteristics** 



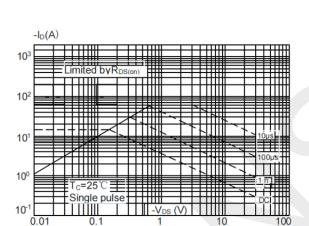
**Gate Charge Characteristics** 



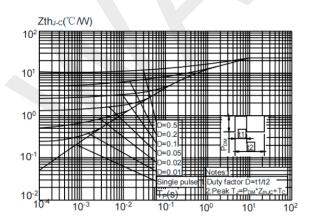
**Capacitance Characteristics** 



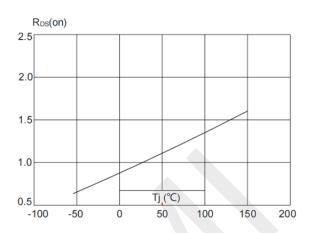
Normalized Breakdown Voltage vs. Junction Temperature



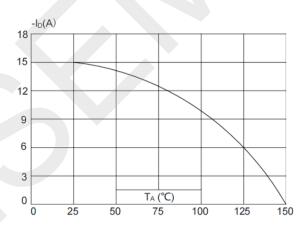
**Maximum Safe Operating Area** 



Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



Normalized on Resistance vs.Junction Temperature

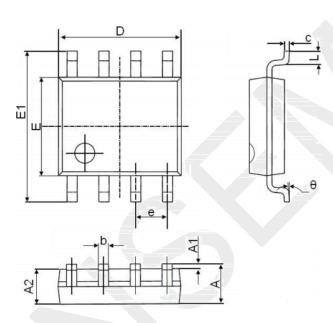


Maximum Continuous Drain Current vs.

Ambient Temperature



# 8.Package Dimensions



Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
E	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.270(BSC)		0.050(BSC)		
L	0.400	1.270	0.016	0.050	
θ	0*	8*	0*	8*	



#### 9.Important Notice

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